

N-Ch and P-Channel MOSFET

General Description

The WSP4063 is the highest performance trench N+P-Channel MOSFET with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The WSP4063 meet the RoHS and Green Product requirement, 100% E_{AS} guaranteed with full function reliability approved.

Features

- 100% UIS Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

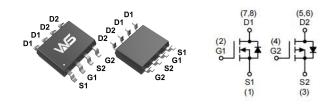
Product Summery

BV _{DSS}	R _{DS(ON)}	I _D
40V	17mΩ	6A
-40V	42mΩ	-5A

Applications

- Synchronous Rectification.
- Motor control.

SOP-8L Pin Configuration



Absolute Maximum Ratings (T_A=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rat	Units		
Syllibol	Farameter		N-Ch	P-Ch	Offics	
V_{DS}	Drain-Source Voltage		40	-40	V	
V_{GS}	Gate-Source Voltage			±20	V	
1 7	Continuous Drain Current	T _C =25°C	6	-5		
l _D ⁷	Continuous Drain Current	T _C =100°C	4.2	-3.7	Α	
I _{DM} ³	Pulse Drain Current		21	-21		
P _D ²	Dower Dissipation	T _C =25°C	2.08	2.08	W	
P _D -	Power Dissipation	T _C =100°C	1.33	1.33	VV	
I _{AS} ³	Single pulse Avalanche Current		12	11	А	
E _{AS} ³	Single pulse Avalanche Energy	L=0.3mH	51	43	mJ	
T _{STG}	Storage Temperature Range		-55 to 150	-55 to 150	°C	
TJ	Operating Junction Temperature Range		-55 to 150	-55 to 150	C	
D 1.4	Thermal Desigtance Junction to Archivet	t≤10s	60	60		
R _{θJA} ^{1,4}	Thermal Resistance-Junction to Ambient	Steady State	100	100	°C/W	
R _{0JC}	Thermal Resistance-Junction to Case		36	36		



Electrical Characteristics (T_J=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250μA	40			V
D	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =5A		17	23	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =4.5V , I_D =5A		23	36	11122
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_{D}=250\mu A$	1.0	1.5	2.3	V
	Drain-Source Leakage Current	V_{DS} =32V , V_{GS} =0V			1.0	
I _{DSS}	Diain-Source Leakage Current	T _J =55°C			30	μA
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V , V _{GS} =±20V			±100	nA
9 _{fs}	Forward Transconductance	V_{DS} =5V , I_{D} =5A		23		S
R_G	Gate Resistance	f=1.0MHz	1.0	2.0	3.1	Ω
Qg	Total Gate Charge (10V)			8.3	12	
Qg	Total Gate Charge (4.5V)	\/ -20\/ \/ -10\/ \ -5		3.9	6	nC
Q _{gs}	Gate-Source Charge	- V _{DS} =20V , V _{GS} =10V , I _D =5A		1.6		nc
Q_{gd}	Gate-Drain Charge			1.4		
T _{d(on)}	Turn-On Delay Time			5.2		
T _r	Rise Time	V_{DS} =20V , V_{GS} =10V , I_{D} =5A		8.6		no
$T_{d(off)}$	Turn-Off Delay Time	$R_{\rm I}$ = 15 Ω , $R_{\rm GFN}$ = 6 Ω		13.5		ns
T _f	Fall Time	32.1		3.4		
C _{iss}	Input Capacitance			408		
C _{oss}	Output Capacitance	V_{DS} =20V , V_{GS} =0V , f =1.0MHz		72		pF
C _{rss}	Reverse Transfer Capacitance			40		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I _S ⁷	Continuous Source Current				6	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =5A		0.7	1.0	V
t _{rr}	Reverse Recovery Time	l _F =5A , di/dt=500A/μs		12		ns
Q _{rr}	Reverse Recovery Charge	1 1 - 5 Α , α Ι/α ι - 300 Α/μ δ		3.5		nC

Note:

- The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The Power dissipation P_{DSM} is based on R_{θJA} t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Single pulse width limited by junction temperature $T_{J(MAX)}$ =150°C.
- 4. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C.
- 9. The maximum current rating is silicon limited



N Channel Typical Operating Characteristics (Cont.)

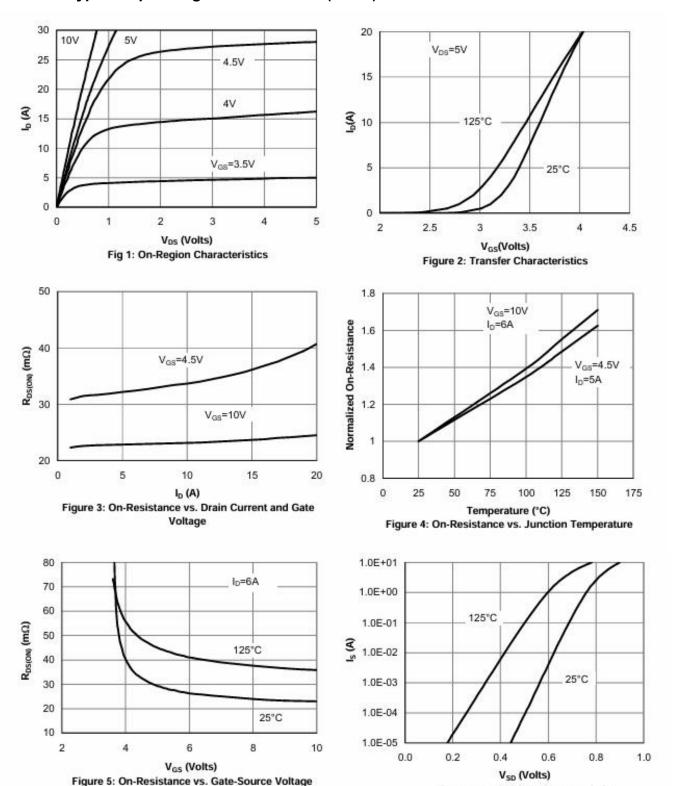


Figure 6: Body-Diode Characteristics



N Channel Typical Operating Characteristics (Cont.)

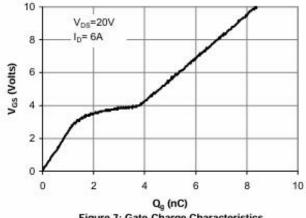


Figure 7: Gate-Charge Characteristics

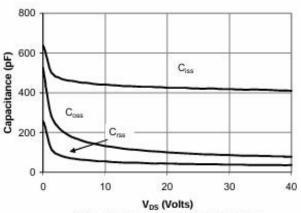


Figure 8: Capacitance Characteristics

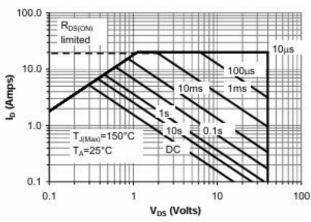


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

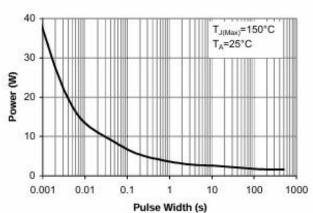


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

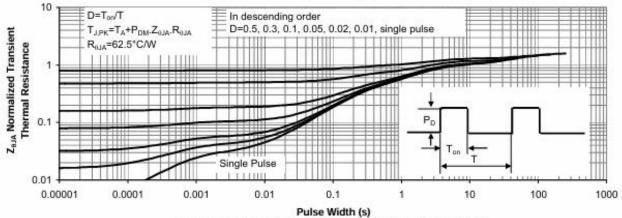


Figure 11: Normalized Maximum Transient Thermal Impedance



N-Ch and P-Channel MOSFET

Electrical Characteristics (T_J=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions		Тур.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250μA	-40			V
В	Static Drain-Source On-Resistance	V _{GS} =-10V , I _D =-5A		42	48	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-4.5V , I _D =-5A	57 64		64	11177
$V_{GS(th)}$	Gate Threshold Voltage	V_{GS} = V_{DS} , I_{D} =-250 μ A	-1.0	-1.7	-2.4	V
	Drain-Source Leakage Current	V_{DS} =-32V , V_{GS} =0V			-1.0	
I _{DSS}	Dialii-Source Leakage Current	T _J =55°C			-30	μA
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V , V _{GS} =±20V			±100	nA
9 _{fs}	Forward Transconductance	V _{DS} =-5V , I _D =-5A		30		S
R_G	Gate Resistance f=1.0MHz			12		Ω
Q_g	Total Gate Charge (10V)			15		
Q_g	Total Gate Charge (4.5V)	\(- 20\\ \\ - 10\\ \ \ - 5A		7		nC
Q_{gs}	Gate-Source Charge	V_{DS} =-20V , V_{GS} =-10V , I_{D} =-5A		2		
Q_{gd}	Gate-Drain Charge			4		
T _{d(on)}	Turn-On Delay Time			8.5		
T _r	Rise Time	V_{DS} =-20V , V_{GS} =-10V , I_{D} =-5A		6.8		
T _{d(off)}	Turn-Off Delay Time	$R_L=15\Omega$, $R_{GEN}=6\Omega$		25		ns
T _f	Fall Time	32.1		11.5		
C _{iss}	Input Capacitance			650		
C _{oss}	Output Capacitance	V_{DS} =-20V , V_{GS} =0V , f =1.0MHz		143		pF
C _{rss}	Reverse Transfer Capacitance			63		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I _S ⁷	Continuous Source Current				-5	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =-5A		-0.7	-1.0	V
t _{rr}	Reverse Recovery Time	I _E =-5A , di/dt=500A/µs		22		ns
Q _{rr}	Reverse Recovery Charge	1 _F 5A , αι/αι-300A/μs		16		nC

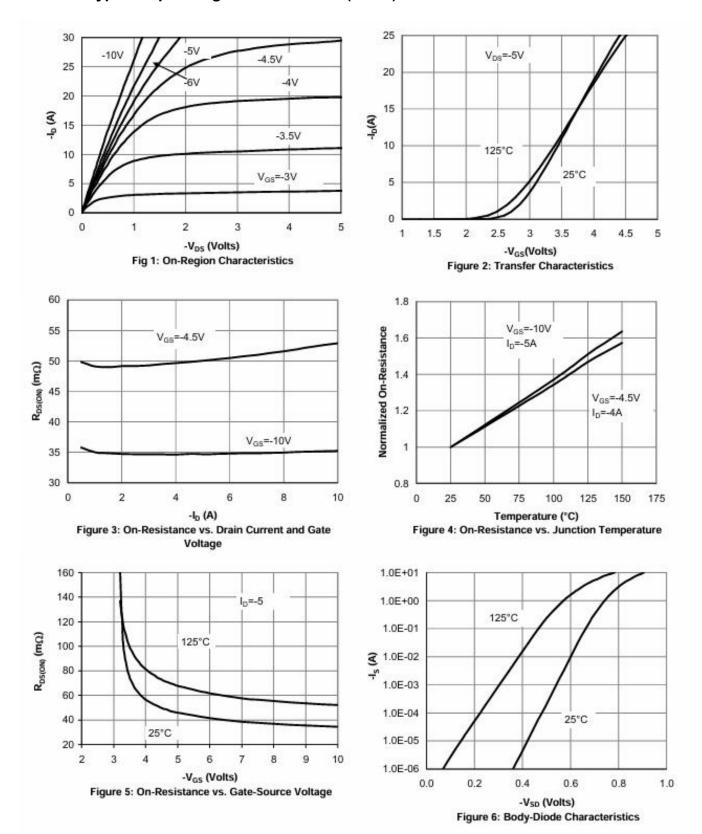
Note:

- 10. The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The Power dissipation P_{DSM} is based on R_{θJA} t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 11. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 12. Single pulse width limited by junction temperature $T_{J(MAX)}$ =150°C.
- 13. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- 14. The static characteristics in Figures 1 to 6 are obtained using $<300\mu s$ pulses, duty cycle 0.5% max.
- 15. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse rating.
- 16. The maximum current rating is package limited.
- 17. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C.

The maximum current rating is silicon limited



P Channel Typical Operating Characteristics (Cont.)





P Channel Typical Operating Characteristics (Cont.)

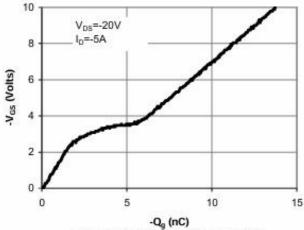


Figure 7: Gate-Charge Characteristics

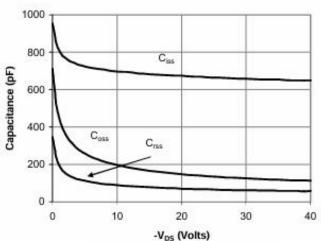


Figure 8: Capacitance Characteristics

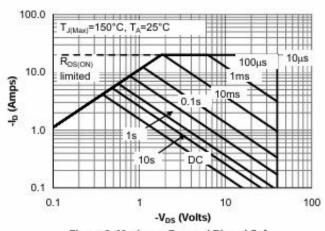


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

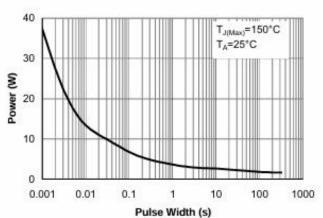


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

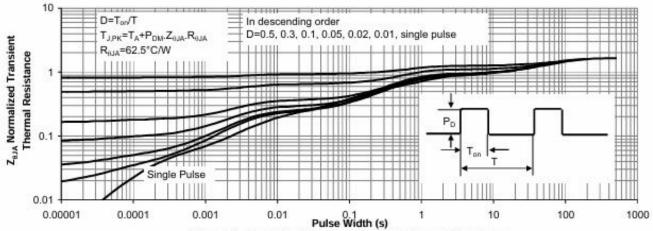
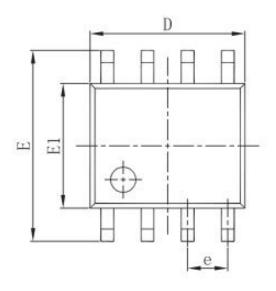
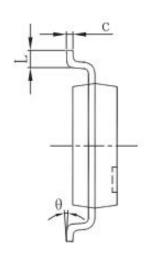


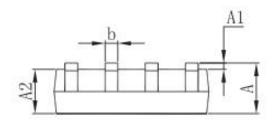
Figure 11: Normalized Maximum Transient Thermal Impedance



Packaging information







Cumbal	Dimensions In Millimet ers		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1.350	1. 750	0, 053	0.069	
A1	0.100	0. 250	0.004	0. 010	
A2	1.350	1.550	0.053	0.061	
b	0. 330	0. 510	0.013	0. 020	
c	0. 170	0. 250	0.007	0. 010	
D	4. 800	5. 000	0.189	0. 197	
e	1.270 (BSC)		0.050 (BSC)		
Е	5. 800	6. 200	0. 228	0. 244	
E1	3.800	4. 000	0.150	0. 157	
L	0.400	1. 270	0.016	0. 050	
θ	0.	8°	0°	8°	



N-Ch and P-Channel MOSFET

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